

Notice of References Cited	Application/Control No. 10/618,379	Applicant(s)/Patent Under Reexamination PATADIA ET AL.	
	Examiner Andrea N. Long	Art Unit 2176	Page 1 of 2

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	L	US-			
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